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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

#### Applications of "[Embedded - Microcontrollers](#)"

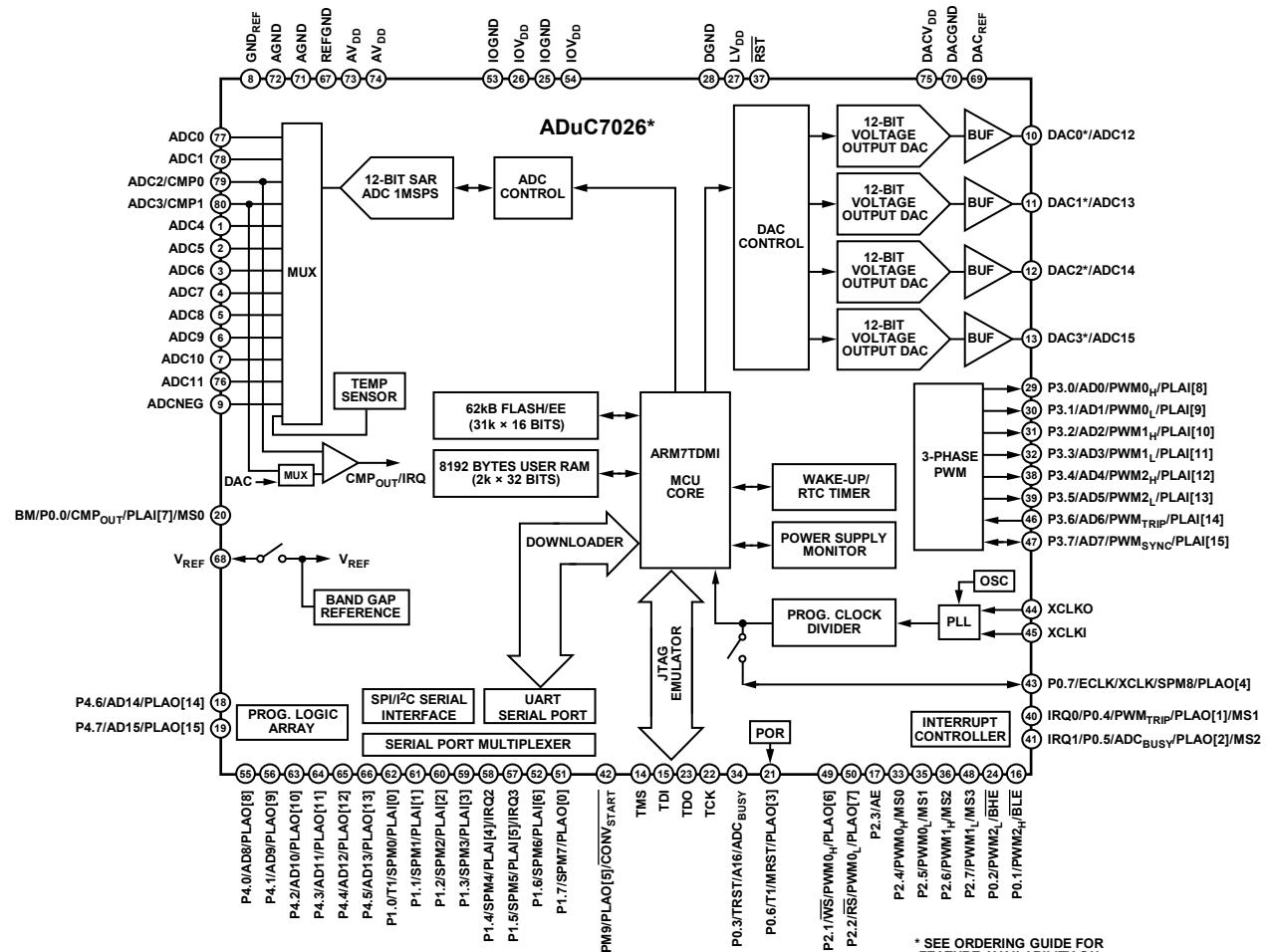
##### Details

Product Status	Obsolete
Core Processor	ARM7®
Core Size	16/32-Bit
Speed	44MHz
Connectivity	EBI/EMI, I²C, SPI, UART/USART
Peripherals	PLA, PWM, PSM, Temp Sensor, WDT
Number of I/O	30
Program Memory Size	32KB (16K x 16)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	1K x 32
Voltage - Supply (Vcc/Vdd)	2.7V ~ 3.6V
Data Converters	A/D 12x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	64-VFQFN Exposed Pad, CSP
Supplier Device Package	64-LFCSP-VQ (9x9)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/analog-devices/aduc7025bcpz32">https://www.e-xfl.com/product-detail/analog-devices/aduc7025bcpz32</a>

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## **DETAILED BLOCK DIAGRAM**



*Figure 11.*

Table 3. External Memory Read Cycle

Parameter	Min	Typ	Max	Unit
CLK <sup>1</sup>	1/MC clock	ns typ × (POWCON[2:0] + 1)		
t <sub>MS_AFTER_CLKH</sub>	4		8	ns
t <sub>ADDR_AFTER_CLKH</sub>	4		16	ns
t <sub>AE_H_AFTER_MS</sub>		½ CLK		
t <sub>AE</sub>		(XMxPAR[14:12] + 1) × CLK		
t <sub>HOLD_ADDR_AFTER_AE_L</sub>		½ CLK + (! XMxPAR[10]) × CLK		
t <sub>RD_L_AFTER_AE_L</sub>		½ CLK + (! XMxPAR[10]+ ! XMxPAR[9]) × CLK		
t <sub>RD_H_AFTER_CLKH</sub>	0		4	
t <sub>RD</sub>		(XMxPAR[3:0] + 1) × CLK		
t <sub>DATA_BEFORE_RD_H</sub>	16			ns
t <sub>DATA_AFTER_RD_H</sub>	8	+ (! XMxPAR[9]) × CLK		
t <sub>RELEASE_MS_AFTER_RD_H</sub>		1 × CLK		

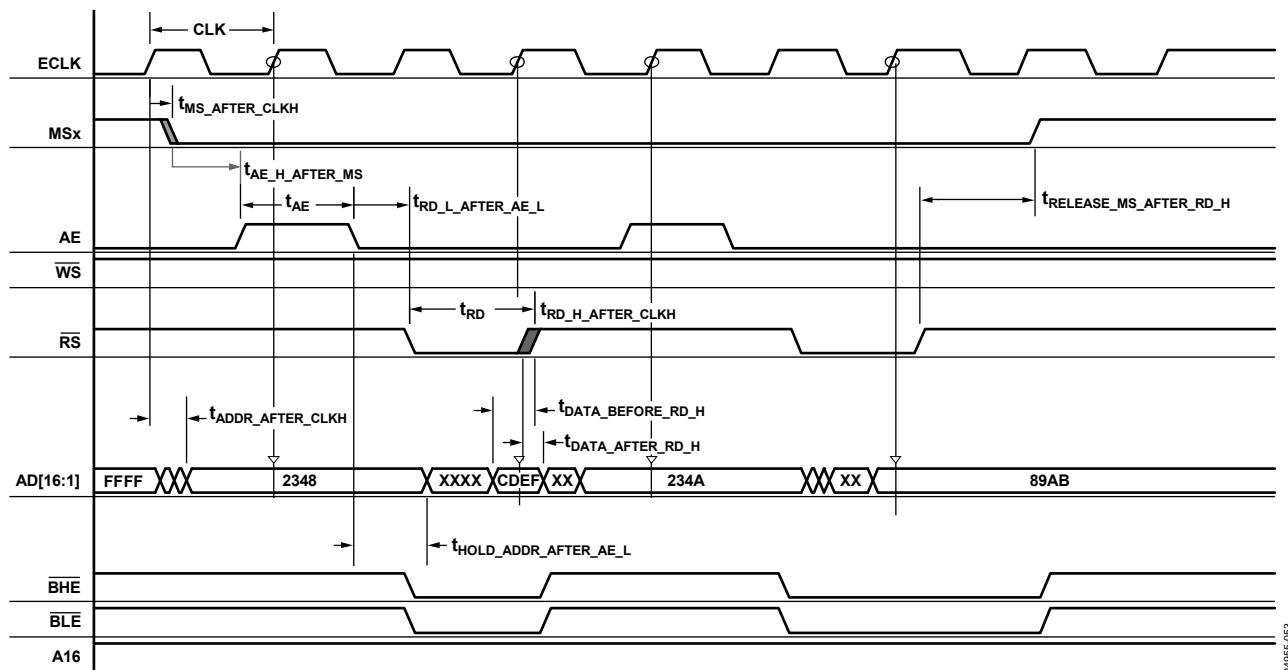
<sup>1</sup> See Table 78.

Figure 13. External Memory Read Cycle (See Table 78)

04955-053

Table 6. SPI Master Mode Timing (Phase Mode = 1)

Parameter	Description	Min	Typ	Max	Unit
$t_{SL}$	SCLK low pulse width <sup>1</sup>		$(\text{SPIDIV} + 1) \times t_{HCLK}$		ns
$t_{SH}$	SCLK high pulse width <sup>1</sup>		$(\text{SPIDIV} + 1) \times t_{HCLK}$		ns
$t_{DAV}$	Data output valid after SCLK edge			25	ns
$t_{DSU}$	Data input setup time before SCLK edge <sup>2</sup>	$1 \times t_{UCLK}$			ns
$t_{DHD}$	Data input hold time after SCLK edge <sup>2</sup>	$2 \times t_{UCLK}$			ns
$t_{DF}$	Data output fall time		5	12.5	ns
$t_{DR}$	Data output rise time		5	12.5	ns
$t_{SR}$	SCLK rise time		5	12.5	ns
$t_{SF}$	SCLK fall time		5	12.5	ns

<sup>1</sup>  $t_{HCLK}$  depends on the clock divider or CD bits in the POWCONMMR.  $t_{HCLK} = t_{UCLK}/2^{CD}$ ; see Figure 67.

<sup>2</sup>  $t_{UCLK} = 23.9$  ns. It corresponds to the 41.78 MHz internal clock from the PLL before the clock divider; see Figure 67.

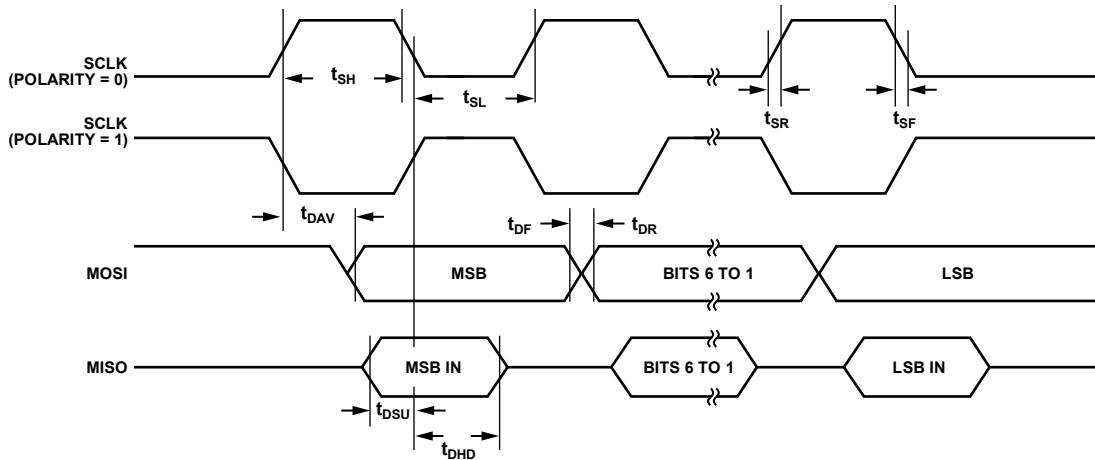


Figure 15. SPI Master Mode Timing (Phase Mode = 1)

0495-605

Table 11. Pin Function Descriptions (ADuC7019/ADuC7020/ADuC7021/ADuC7022)

Pin No.			Mnemonic	Description
7019/7020	7021	7022		
38	37	36	ADC0	Single-Ended or Differential Analog Input 0.
39	38	37	ADC1	Single-Ended or Differential Analog Input 1.
40	39	38	ADC2/CMP0	Single-Ended or Differential Analog Input 2/Comparator Positive Input.
1	40	39	ADC3/CMP1	Single-Ended or Differential Analog Input 3 (Buffered Input on ADuC7019)/ Comparator Negative Input.
2	1	40	ADC4	Single-Ended or Differential Analog Input 4.
-	2	1	ADC5	Single-Ended or Differential Analog Input 5.
-	3	2	ADC6	Single-Ended or Differential Analog Input 6.
-	4	3	ADC7	Single-Ended or Differential Analog Input 7.
-	-	4	ADC8	Single-Ended or Differential Analog Input 8.
-	-	5	ADC9	Single-Ended or Differential Analog Input 9.
3	5	6	GND <sub>REF</sub>	Ground Voltage Reference for the ADC. For optimal performance, the analog power supply should be separated from IOGND and DGND.
4	6	-	DAC0/ADC12	DAC0 Voltage Output/Single-Ended or Differential Analog Input 12.
5	7	-	DAC1/ADC13	DAC1 Voltage Output/Single-Ended or Differential Analog Input 13.
6	-	-	DAC2/ADC14	DAC2 Voltage Output/Single-Ended or Differential Analog Input 14.
7	-	-	DAC3/ADC15	DAC3 Voltage Output on ADuC7020. On the ADuC7019, a 10 nF capacitor must be connected between this pin and AGND/Single-Ended or Differential Analog Input 15 (see Figure 53).
8	8	7	TMS	Test Mode Select, JTAG Test Port Input. Debug and download access. This pin has an internal pull-up resistor to IOV <sub>DD</sub> . In some cases, an external pull-up resistor (~100K) is also required to ensure that the part does not enter an erroneous state.
9	9	8	TDI	Test Data In, JTAG Test Port Input. Debug and download access.
10	10	9	BM/P0.0/CMP <sub>OUT</sub> /PLAI[7]	Multifunction I/O Pin. Boot Mode (BM). The ADuC7019/20/21/22 enter serial download mode if BM is low at reset and execute code if BM is pulled high at reset through a 1 kΩ resistor/General-Purpose Input and Output Port 0.0/Voltage Comparator Output/Programmable Logic Array Input Element 7.
11	11	10	P0.6/T1/MRST/PLAO[3]	Multifunction Pin. Driven low after reset. General-Purpose Output Port 0.6/Timer1 Input/Power-On Reset Output/Programmable Logic Array Output Element 3.
12	12	11	TCK	Test Clock, JTAG Test Port Input. Debug and download access. This pin has an internal pull-up resistor to IOV <sub>DD</sub> . In some cases an external pull-up resistor (~100K) is also required to ensure that the part does not enter an erroneous state.
13	13	12	TDO	Test Data Out, JTAG Test Port Output. Debug and download access.
14	14	13	IOGND	Ground for GPIO (see Table 78). Typically connected to DGND.
15	15	14	IOV <sub>DD</sub>	3.3 V Supply for GPIO (see Table 78) and Input of the On-Chip Voltage Regulator.
16	16	15	LV <sub>DD</sub>	2.6 V Output of the On-Chip Voltage Regulator. This output must be connected to a 0.47 μF capacitor to DGND only.
17	17	16	DGND	Ground for Core Logic.
18	18	17	P0.3/TRST/ADC <sub>BUSY</sub>	General-Purpose Input and Output Port 0.3/Test Reset, JTAG Test Port Input/ADC <sub>BUSY</sub> Signal Output.
19	19	18	RST	Reset Input, Active Low.
20	20	19	IRQ0/P0.4/PWM <sub>TRIP</sub> /PLAO[1]	Multifunction I/O Pin. External Interrupt Request 0, Active High/General-Purpose Input and Output Port 0.4/PWM Trip External Input/Programmable Logic Array Output Element 1.
21	21	20	IRQ1/P0.5/ADC <sub>BUSY</sub> /PLAO[2]	Multifunction I/O Pin. External Interrupt Request 1, Active High/General-Purpose Input and Output Port 0.5/ADC <sub>BUSY</sub> Signal Output/Programmable Logic Array Output Element 2.

Pin No.	Mnemonic	Description
37	P3.6/PWM <sub>TRIP</sub> /PLAI[14]	General-Purpose Input and Output Port 3.6/PWM Safety Cutoff/Programmable Logic Array Input Element 14.
38	P3.7/PWM <sub>SYNC</sub> /PLAI[15]	General-Purpose Input and Output Port 3.7/PWM Synchronization Input and Output/Programmable Logic Array Input Element 15.
39	P1.7/SPM7/PLAO[0]	Serial Port Multiplexed. General-Purpose Input and Output Port 1.7/UART, SPI/Programmable Logic Array Output Element 0.
40	P1.6/SPM6/PLAI[6]	Serial Port Multiplexed. General-Purpose Input and Output Port 1.6/UART, SPI/Programmable Logic Array Input Element 6.
41	IOGND	Ground for GPIO (see Table 78). Typically connected to DGND.
42	IOV <sub>DD</sub>	3.3 V Supply for GPIO (see Table 78) and Input of the On-Chip Voltage Regulator.
43	P4.0/PLAO[8]	General-Purpose Input and Output Port 4.0/Programmable Logic Array Output Element 8.
44	P4.1/PLAO[9]	General-Purpose Input and Output Port 4.1/Programmable Logic Array Output Element 9.
45	P1.5/SPM5/PLAI[5]/IRQ3	Serial Port Multiplexed. General-Purpose Input and Output Port 1.5/UART, SPI/Programmable Logic Array Input Element 5/External Interrupt Request 3, Active High.
46	P1.4/SPM4/PLAI[4]/IRQ2	Serial Port Multiplexed. General-Purpose Input and Output Port 1.4/UART, SPI/Programmable Logic Array Input Element 4/External Interrupt Request 2, Active High.
47	P1.3/SPM3/PLAI[3]	Serial Port Multiplexed. General-Purpose Input and Output Port 1.3/UART, I2C1/Programmable Logic Array Input Element 3.
48	P1.2/SPM2/PLAI[2]	Serial Port Multiplexed. General-Purpose Input and Output Port 1.2/UART, I2C1/Programmable Logic Array Input Element 2.
49	P1.1/SPM1/PLAI[1]	Serial Port Multiplexed. General-Purpose Input and Output Port 1.1/UART, I2C0/Programmable Logic Array Input Element 1.
50	P1.0/T1/SPM0/PLAI[0]	Serial Port Multiplexed. General-Purpose Input and Output Port 1.0/Timer1 Input/UART, I2C0/Programmable Logic Array Input Element 0.
51	P4.2/PLAO[10]	General-Purpose Input and Output Port 4.2/Programmable Logic Array Output Element 10.
52	P4.3/PLAO[11]	General-Purpose Input and Output Port 4.3/Programmable Logic Array Output Element 11.
53	P4.4/PLAO[12]	General-Purpose Input and Output Port 4.4/Programmable Logic Array Output Element 12.
54	P4.5/PLAO[13]	General-Purpose Input and Output Port 4.5/Programmable Logic Array Output Element 13.
55	V <sub>REF</sub>	2.5 V Internal Voltage Reference. Must be connected to a 0.47 $\mu$ F capacitor when using the internal reference.
56	DAC <sub>REF</sub>	External Voltage Reference for the DACs. Range: DACGND to DACV <sub>DD</sub> .
57	DACGND	Ground for the DAC. Typically connected to AGND.
58	AGND	Analog Ground. Ground reference point for the analog circuitry.
59	AV <sub>DD</sub>	3.3 V Analog Power.
60	DACV <sub>DD</sub>	3.3 V Power Supply for the DACs. Must be connected to AV <sub>DD</sub> .
61	ADC0	Single-Ended or Differential Analog Input 0.
62	ADC1	Single-Ended or Differential Analog Input 1.
63	ADC2/CMP0	Single-Ended or Differential Analog Input 2/Comparator Positive Input.
64	ADC3/CMP1	Single-Ended or Differential Analog Input 3/Comparator Negative Input.
0	EP	Exposed Pad. The pin configuration for the ADuC7024/ADuC7025 LFCSP_VQ has an exposed pad that must be soldered for mechanical purposes and left unconnected.

Pin No.	Mnemonic	Description
E1	TMS	JTAG Test Port Input, Test Mode Select. Debug and download access.
E2	BM/P0.0/CMP <sub>OUT</sub> /PLAI[7]	Multifunction I/O Pin. Boot mode. The ADuC7029 enters UART download mode if BM is low at reset and executes code if BM is pulled high at reset through a 1 kΩ resistor/General-Purpose Input and Output Port 0.0/Voltage Comparator Output/Programmable Logic Array Input Element 7.
E3	DAC2/ADC14	DAC2 Voltage Output/ADC Input 14.
E4	IOV <sub>DD</sub>	3.3 V Supply for GPIO (see Table 78) and Input of the On-Chip Voltage Regulator.
E5	P3.2/PWM1 <sub>H</sub> /PLAI[10]	General-Purpose Input and Output Port 3.2/PWM Phase 1 High-Side Output/Programmable Logic Array Input Element 10.
E6	P3.5/PWM2 <sub>L</sub> /PLAI[13]	General-Purpose Input and Output Port 3.5/PWM Phase 2 Low-Side Output/Programmable Logic Array Input Element 13.
E7	P0.7/ECLK/XCLK/SPM8/PLAO[4]	Serial Port Multiplexed. General-Purpose Input and Output Port 0.7/Output for External Clock Signal/Input to the Internal Clock Generator Circuits/UART/Programmable Logic Array Output Element 4.
F1	TDI	JTAG Test Port Input, Test Data In. Debug and download access.
F2	P0.6/T1/MRST/PLAO[3]	Multifunction Pin, Driven Low After Reset. General-Purpose Output Port 0.6/Timer1 Input/Power-On Reset Output/Programmable Logic Array Output Element 3.
F3	IOGND	Ground for GPIO (see Table 78). Typically connected to DGND.
F4	P3.1/PWM0 <sub>L</sub> /PLAI[9]	General-Purpose Input and Output Port 3.1/PWM Phase 0 Low-Side Output/Programmable Logic Array Input Element 9.
F5	P3.0/PWM0 <sub>H</sub> /PLAI[8]	General-Purpose Input and Output Port 3.0/PWM Phase 0 High-Side Output/Programmable Logic Array Input Element 8.
F6	<u>RST</u>	Reset Input, Active Low.
F7	P2.0/SPM9/PLAO[5]/CONV <sub>START</sub>	Serial Port Multiplexed. General-Purpose Input and Output Port 2.0/UART/Programmable Logic Array Output Element 5/Start Conversion Input Signal for ADC.
G1	TCK	JTAG Test Port Input, Test Clock. Debug and download access.
G2	TDO	JTAG Test Port Output, Test Data Out. Debug and download access.
G3	LV <sub>DD</sub>	2.6 V Output of the On-Chip Voltage Regulator. This output must be connected to a 0.47 μF capacitor to DGND only.
G4	DGND	Ground for Core Logic.
G5	P0.3/TRST/ADC <sub>BUSY</sub>	General-Purpose Input and Output Port 0.3/JTAG Test Port Input, Test Reset/ADC <sub>BUSY</sub> Signal Output.
G6	IRQ0/P0.4/PWM <sub>TRIP</sub> /PLAO[1]	Multifunction I/O Pin. External Interrupt Request 0, Active High/General-Purpose Input and Output Port 0.4/PWM Trip External Input/Programmable Logic Array Output Element 1.
G7	IRQ1/P0.5/ADC <sub>BUSY</sub> /PLAO[2]	Multifunction I/O Pin. External Interrupt Request 1, Active High/General-Purpose Input and Output Port 0.5/ADC <sub>BUSY</sub> Signal Output/Programmable Logic Array Output Element 2.

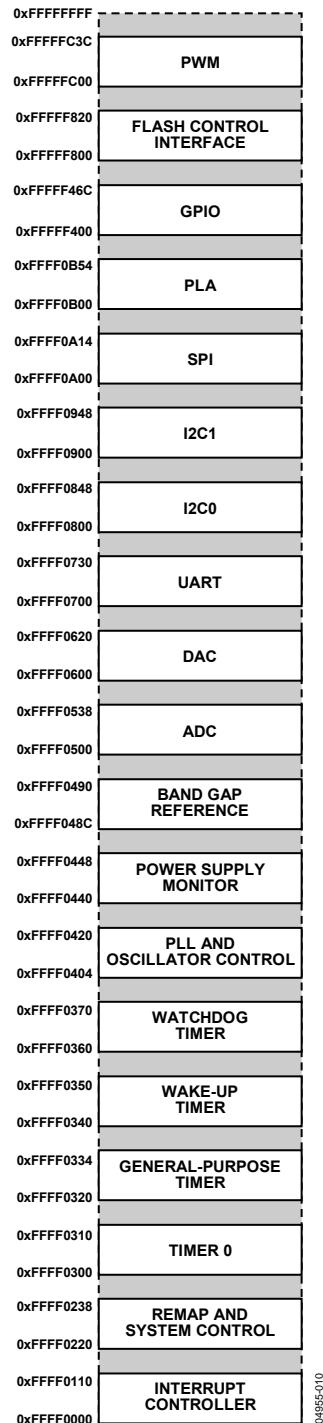


Figure 47. Memory Mapped Registers

Table 16. Complete MMR List

Address	Name	Byte	Access Type	Default Value	Page
IRQ Address Base = 0xFFFF0000					
0x0000	IRQSTA	4	R	0x00000000	83
0x0004	IRQSIG <sup>1</sup>	4	R	0x00XXX000	83
0x0008	IRQEN	4	R/W	0x00000000	83
0x000C	IRQCLR	4	W	0x00000000	83
0x0010	SWICFG	4	W	0x00000000	84
0x0100	FIQSTA	4	R	0x00000000	84
0x0104	FIQSIG <sup>1</sup>	4	R	0x00XXX000	84
0x0108	FIQEN	4	R/W	0x00000000	84
0x010C	FIQCLR	4	W	0x00000000	84

<sup>1</sup>Depends on the level on the external interrupt pins (P0.4, P0.5, P1.4, and P1.5).

System Control Address Base = 0xFFFF0200

0x0220	REMAP	1	R/W	0xXX <sup>1</sup>	55
0x0230	RSTSTA	1	R/W	0x01	55
0x0234	RSTCLR	1	W	0x00	55

<sup>1</sup>Depends on the model.

Timer Address Base = 0xFFFF0300

0x0300	T0LD	2	R/W	0x0000	85
0x0304	T0VAL	2	R	0xFFFF	85
0x0308	T0CON	2	R/W	0x0000	85
0x030C	T0CLRI	1	W	0xFF	85
0x0320	T1LD	4	R/W	0x00000000	86
0x0324	T1VAL	4	R	0xFFFFFFFF	86
0x0328	T1CON	2	R/W	0x0000	86
0x032C	T1CLRI	1	W	0xFF	87
0x0330	T1CAP	4	R/W	0x00000000	87
0x0340	T2LD	4	R/W	0x00000000	87
0x0344	T2VAL	4	R	0xFFFFFFFF	87
0x0348	T2CON	2	R/W	0x0000	87
0x034C	T2CLRI	1	W	0xFF	88
0x0360	T3LD	2	R/W	0x0000	88
0x0364	T3VAL	2	R	0xFFFF	88
0x0368	T3CON	2	R/W	0x0000	88
0x036C	T3CLRI	1	W	0x00	89

PLL Base Address = 0xFFFF0400

0x0404	POWKEY1	2	W	0x0000	60
0x0408	POWCON	2	R/W	0x0003	60
0x040C	POWKEY2	2	W	0x0000	60
0x0410	PLLKEY1	2	W	0x0000	60
0x0414	PLLCON	1	R/W	0x21	60
0x0418	PLLKEY2	2	W	0x0000	60

PSM Address Base = 0xFFFF0440

0x0440	PSMCON	2	R/W	0x0008	57
0x0444	CMPCON	2	R/W	0x0000	58

Table 22. ADCCN MMR Bit Designation

Bit	Value	Description
7:5		Reserved.
4:0		Negative channel selection bits.
	00000	ADC0.
	00001	ADC1.
	00010	ADC2.
	00011	ADC3.
	00100	ADC4.
	00101	ADC5.
	00110	ADC6.
	00111	ADC7.
	01000	ADC8.
	01001	ADC9.
	01010	ADC10.
	01011	ADC11.
	01100	DAC0/ADC12.
	01101	DAC1/ADC13.
	01110	DAC2/ADC14.
	01111	DAC3/ADC15.
	10000	Internal reference (self-diagnostic feature).
	Others	Reserved.

Table 23. ADCSTA Register

Name	Address	Default Value	Access
ADCSTA	0xFFFF050C	0x00	R

ADCSTA is an ADC status register that indicates when an ADC conversion result is ready. The ADCSTA register contains only one bit, ADCReady (Bit 0), representing the status of the ADC. This bit is set at the end of an ADC conversion, generating an ADC interrupt. It is cleared automatically by reading the ADCDAT register. When the ADC is performing a conversion, the status of the ADC can be read externally via the ADC<sub>BUSY</sub> pin. This pin is high during a conversion. When the conversion is finished, ADC<sub>BUSY</sub> goes back low. This information can be available on P0.5 (see the General-Purpose Input/Output section) if enabled in the ADCCON register.

Table 24. ADCDAT Register

Name	Address	Default Value	Access
ADCDAT	0xFFFF0510	0x00000000	R

ADCDAT is an ADC data result register. It holds the 12-bit ADC result as shown in Figure 51.

Table 25. ADCRST Register

Name	Address	Default Value	Access
ADCRST	0xFFFF0514	0x00	R/W

ADCRST resets the digital interface of the ADC. Writing any value to this register resets all the ADC registers to their default values.

Table 26. ADCGN Register

Name	Address	Default Value	Access
ADCGN	0xFFFF0530	0x0200	R/W

ADCGN is a 10-bit gain calibration register.

Table 27. ADCOF Register

Name	Address	Default Value	Access
ADCOF	0xFFFF0534	0x0200	R/W

ADCOF is a 10-bit offset calibration register.

## CONVERTER OPERATION

The ADC incorporates a successive approximation (SAR) architecture involving a charge-sampled input stage. This architecture can operate in three modes: differential, pseudo differential, and single-ended.

### Differential Mode

The ADuC7019/20/21/22/24/25/26/27/28/29 each contain a successive approximation ADC based on two capacitive DACs. Figure 54 and Figure 55 show simplified schematics of the ADC in acquisition and conversion phase, respectively. The ADC comprises control logic, a SAR, and two capacitive DACs. In Figure 54 (the acquisition phase), SW3 is closed and SW1 and SW2 are in Position A. The comparator is held in a balanced condition, and the sampling capacitor arrays acquire the differential signal on the input.

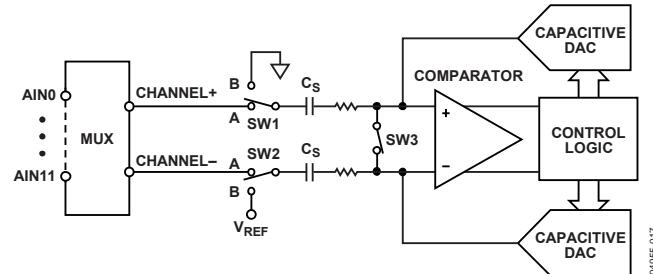


Figure 54. ADC Acquisition Phase

When the ADC starts a conversion, as shown in Figure 55, SW3 opens, and then SW1 and SW2 move to Position B. This causes the comparator to become unbalanced. Both inputs are disconnected once the conversion begins. The control logic and the charge redistribution DACs are used to add and subtract fixed amounts of charge from the sampling capacitor arrays to bring the comparator back into a balanced condition. When the comparator is rebalanced, the conversion is complete. The control logic generates the ADC output code. The output impedances of the sources driving the V<sub>IN+</sub> and V<sub>IN-</sub> input voltage pins must be matched; otherwise, the two inputs have different settling times, resulting in errors.

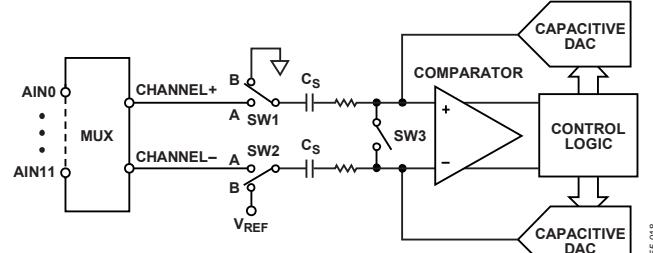


Figure 55. ADC Conversion Phase

## NONVOLATILE FLASH/EE MEMORY

The ADuC7019/20/21/22/24/25/26/27/28/29 incorporate Flash/EE memory technology on-chip to provide the user with nonvolatile, in-circuit reprogrammable memory space.

Like EEPROM, flash memory can be programmed in-system at a byte level, although it must first be erased. The erase is performed in page blocks. As a result, flash memory is often and more correctly referred to as Flash/EE memory.

Overall, Flash/EE memory represents a step closer to the ideal memory device that includes nonvolatility, in-circuit programmability, high density, and low cost. Incorporated in the ADuC7019/20/21/22/24/25/26/27/28/29, Flash/EE memory technology allows the user to update program code space in-circuit, without the need to replace one-time programmable (OTP) devices at remote operating nodes.

Each part contains a 64 kB array of Flash/EE memory. The lower 62 kB is available to the user and the upper 2 kB contain permanently embedded firmware, allowing in-circuit serial download. These 2 kB of embedded firmware also contain a power-on configuration routine that downloads factory-calibrated coefficients to the various calibrated peripherals (such as ADC, temperature sensor, and band gap references). This 2 kB embedded firmware is hidden from user code.

### **Flash/EE Memory Reliability**

The Flash/EE memory arrays on the parts are fully qualified for two key Flash/EE memory characteristics: Flash/EE memory cycling endurance and Flash/EE memory data retention.

Endurance quantifies the ability of the Flash/EE memory to be cycled through many program, read, and erase cycles. A single endurance cycle is composed of four independent, sequential events, defined as

1. Initial page erase sequence
2. Read/verify sequence (single Flash/EE)
3. Byte program sequence memory
4. Second read/verify sequence (endurance cycle)

In reliability qualification, every half word (16-bit wide) location of the three pages (top, middle, and bottom) in the Flash/EE memory is cycled 10,000 times from 0x0000 to 0xFFFF. As indicated in Table 1, the Flash/EE memory endurance qualification is carried out in accordance with JEDEC Retention Lifetime Specification A117 over the industrial temperature range of  $-40^{\circ}$  to  $+125^{\circ}$ C. The results allow the specification of a minimum endurance figure over a supply temperature of 10,000 cycles.

Retention quantifies the ability of the Flash/EE memory to retain its programmed data over time. Again, the parts are qualified in accordance with the formal JEDEC Retention Lifetime Specification (A117) at a specific junction temperature ( $T_j = 85^{\circ}$ C). As part of this qualification procedure, the Flash/EE memory is cycled to its specified endurance limit, described in Table 1, before data retention is characterized. This means that the Flash/EE memory is guaranteed to retain its data for its fully specified retention lifetime every time the Flash/EE memory is reprogrammed. In addition, note that retention lifetime, based on an activation energy of 0.6 eV, derates with  $T_j$  as shown in Figure 61.

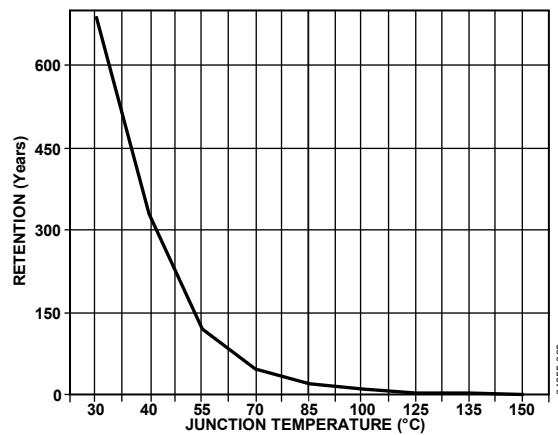


Figure 61. Flash/EE Memory Data Retention

## **PROGRAMMING**

The 62 kB of Flash/EE memory can be programmed in-circuit, using the serial download mode or the provided JTAG mode.

### **Serial Downloading (In-Circuit Programming)**

The ADuC7019/20/21/22/24/25/26/27/28/29 facilitate code download via the standard UART serial port or via the I<sup>2</sup>C port. The parts enter serial download mode after a reset or power cycle if the BM pin is pulled low through an external 1 kΩ resistor. After a part is in serial download mode, the user can download code to the full 62 kB of Flash/EE memory while the device is in-circuit in its target application hardware. An executable PC serial download is provided as part of the development system for serial downloading via the UART. The AN-806 Application Note describes the protocol for serial downloading via the I<sup>2</sup>C.

### **JTAG Access**

The JTAG protocol uses the on-chip JTAG interface to facilitate code download and debug.

## SECURITY

The 62 kB of Flash/EE memory available to the user can be read and write protected.

Bit 31 of the FEEPROM/FEEHIDE MMR (see Table 42) protects the 62 kB from being read through JTAG programming mode. The other 31 bits of this register protect writing to the flash memory. Each bit protects four pages, that is, 2 kB. Write protection is activated for all types of access.

### Three Levels of Protection

- Protection can be set and removed by writing directly into FEEHIDE MMR. This protection does not remain after reset.
- Protection can be set by writing into the FEEPROM MMR. It takes effect only after a save protection command (0x0C) and a reset. The FEEPROM MMR is protected by a key to avoid direct access. The key is saved once and must be entered again to modify FEEPROM. A mass erase sets the key back to 0xFFFF but also erases all the user code.
- Flash can be permanently protected by using the FEEPROM MMR and a particular value of key: 0xDEADDEAD. Entering the key again to modify the FEEPROM register is not allowed.

### Sequence to Write the Key

1. Write the bit in FEEPROM corresponding to the page to be protected.
2. Enable key protection by setting Bit 6 of FEEMOD (Bit 5 must equal 0).
3. Write a 32-bit key in FEEADR and FEEDAT.
4. Run the write key command 0x0C in FEECON; wait for the read to be successful by monitoring FEESTA.
5. Reset the part.

To remove or modify the protection, the same sequence is used with a modified value of FEEPROM. If the key chosen is the value 0xDEAD, the memory protection cannot be removed. Only a mass erase unprotects the part, but it also erases all user code.

The sequence to write the key is illustrated in the following example (this protects writing Page 4 to Page 7 of the Flash):

```
FEEPROM=0xFFFFFFFFFD; //Protect pages 4 to 7
FEEMOD=0x48; //Write key enable
FEEADR=0x1234; //16 bit key value
FEEDAT=0x5678; //16 bit key value
FEECON= 0x0C; // Write key command
```

The same sequence should be followed to protect the part permanently with FEEADR = 0xDEAD and FEEDAT = 0xDEAD.

## FLASH/EE CONTROL INTERFACE

Serial and JTAG programming use the Flash/EE control interface, which includes the eight MMRs outlined in this section.

**Table 31. FEESTA Register**

Name	Address	Default Value	Access
FEESTA	0xFFFFF800	0x20	R

FEESTA is a read-only register that reflects the status of the flash control interface as described in Table 32.

**Table 32. FEESTA MMR Bit Designations**

Bit	Description
15:6	Reserved.
5	Reserved.
4	Reserved.
3	Flash interrupt status bit. Set automatically when an interrupt occurs, that is, when a command is complete and the Flash/EE interrupt enable bit in the FEEMOD register is set. Cleared when reading the FEESTA register.
2	Flash/EE controller busy. Set automatically when the controller is busy. Cleared automatically when the controller is not busy.
1	Command fail. Set automatically when a command completes unsuccessfully. Cleared automatically when reading the FEESTA register.
0	Command pass. Set by the MicroConverter when a command completes successfully. Cleared automatically when reading the FEESTA register.

**Table 33. FEEMOD Register**

Name	Address	Default Value	Access
FEEMOD	0xFFFFF804	0x0000	R/W

FEEMOD sets the operating mode of the flash control interface. Table 34 shows FEEMOD MMR bit designations.

**Table 34. FEEMOD MMR Bit Designations**

Bit	Description
15:9	Reserved.
8	Reserved. This bit should always be set to 0.
7:5	Reserved. These bits should always be set to 0 except when writing keys. See the Sequence to Write the Key section.
4	Flash/EE interrupt enable. Set by user to enable the Flash/EE interrupt. The interrupt occurs when a command is complete. Cleared by user to disable the Flash/EE interrupt.
3	Erase/write command protection. Set by user to enable the erase and write commands. Cleared to protect the Flash against the erase/write command.
2:0	Reserved. These bits should always be set to 0.

## OTHER ANALOG PERIPHERALS

### DAC

The ADuC7019/20/21/22/24/25/26/27/28/29 incorporate two, three, or four 12-bit voltage output DACs on-chip, depending on the model. Each DAC has a rail-to-rail voltage output buffer capable of driving 5 kΩ/100 pF.

Each DAC has three selectable ranges: 0 V to  $V_{REF}$  (internal band gap 2.5 V reference), 0 V to  $DAC_{REF}$ , and 0 V to  $AV_{DD}$ .  $DAC_{REF}$  is equivalent to an external reference for the DAC. The signal range is 0 V to  $AV_{DD}$ .

### MMRs Interface

Each DAC is independently configurable through a control register and a data register. These two registers are identical for the four DACs. Only  $DAC0CON$  (see Table 50) and  $DAC0DAT$  (see Table 52) are described in detail in this section.

**Table 49. DACxCON Registers**

Name	Address	Default Value	Access
$DAC0CON$	0xFFFF0600	0x00	R/W
$DAC1CON$	0xFFFF0608	0x00	R/W
$DAC2CON$	0xFFFF0610	0x00	R/W
$DAC3CON$	0xFFFF0618	0x00	R/W

**Table 50. DAC0CON MMR Bit Designations**

Bit	Name	Value	Description
7:6			Reserved.
5	$DACCLK$		DAC update rate. Set by user to update the DAC using Timer1. Cleared by user to update the DAC using HCLK (core clock).
4	$DACCLR$		DAC clear bit. Set by user to enable normal DAC operation. Cleared by user to reset data register of the DAC to 0.
3			Reserved. This bit should be left at 0.
2			Reserved. This bit should be left at 0.
1:0		00	DAC range bits. Power-down mode. The DAC output is in three-state.
		01	0 V to $DAC_{REF}$ range.
		10	0 V to $V_{REF}$ (2.5 V) range.
		11	0 V to $AV_{DD}$ range.

**Table 51. DACxDAT Registers**

Name	Address	Default Value	Access
$DAC0DAT$	0xFFFF0604	0x00000000	R/W
$DAC1DAT$	0xFFFF060C	0x00000000	R/W
$DAC2DAT$	0xFFFF0614	0x00000000	R/W
$DAC3DAT$	0xFFFF061C	0x00000000	R/W

**Table 52. DAC0DAT MMR Bit Designations**

Bit	Description
31:28	Reserved.
27:16	12-bit data for DAC0.
15:0	Reserved.

### Using the DACs

The on-chip DAC architecture consists of a resistor string DAC followed by an output buffer amplifier. The functional equivalent is shown in Figure 63.

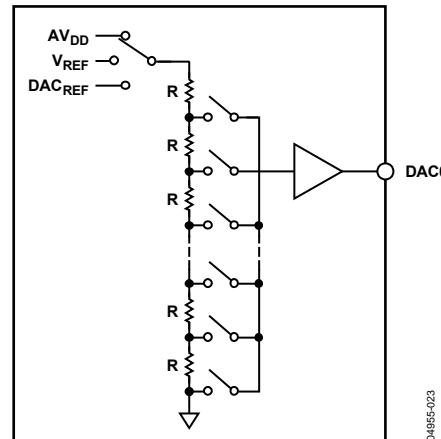


Figure 63. DAC Structure

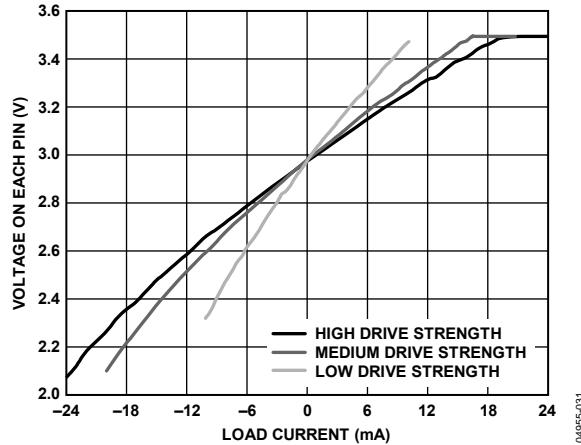
04955-023

As illustrated in Figure 63, the reference source for each DAC is user-selectable in software. It can be  $AV_{DD}$ ,  $V_{REF}$ , or  $DAC_{REF}$ . In 0-to- $AV_{DD}$  mode, the DAC output transfer function spans from 0 V to the voltage at the  $AV_{DD}$  pin. In 0-to- $DAC_{REF}$  mode, the DAC output transfer function spans from 0 V to the voltage at the  $DAC_{REF}$  pin. In 0-to- $V_{REF}$  mode, the DAC output transfer function spans from 0 V to the internal 2.5 V reference,  $V_{REF}$ .

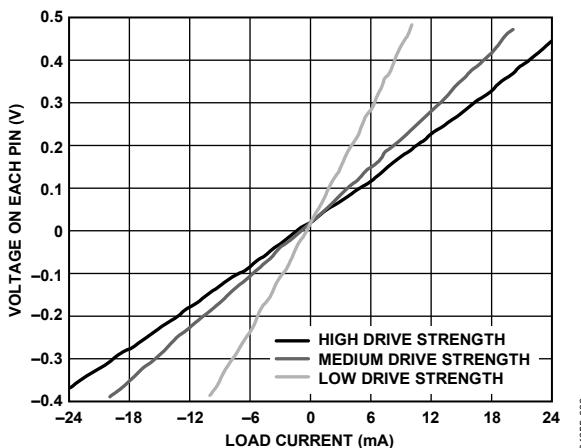
The DAC output buffer amplifier features a true, rail-to-rail output stage implementation. This means that when unloaded, each output is capable of swinging to within less than 5 mV of both  $AV_{DD}$  and ground. Moreover, the DAC's linearity specification (when driving a 5 kΩ resistive load to ground) is guaranteed through the full transfer function, except Code 0 to Code 100, and, in 0-to- $AV_{DD}$  mode only, Code 3995 to Code 4095.

**Table 83. GPIO Drive Strength Control Bits Descriptions**

<b>Control Bits Value</b>	<b>Description</b>
00	Medium drive strength.
01	Low drive strength.
1x	High drive strength.



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04955-032

The drive strength bits can be written to one time only after reset. More writing to related bits has no effect on changing drive strength. The GPIO drive strength and pull-up disable is not always adjustable for the GPIO port. Some control bits cannot be changed (see Table 84).

**Table 84. GPxPAR Control Bits Access Descriptions**

<b>Bit</b>	<b>GP0PAR</b>	<b>GP1PAR</b>
31	Reserved	Reserved
30 to 29	R/W	R/W
28	R/W	R/W
27	Reserved	Reserved
26 to 25	R/W	R/W
24	R/W	R/W
23	Reserved	Reserved
22 to 21	R/W	R (b00)
20	R/W	R/W
19	Reserved	Reserved
18 to 17	R (b00)	R (b00)
16	R/W	R/W
15	Reserved	Reserved
14 to 13	R (b00)	R (b00)
12	R/W	R/W
11	Reserved	Reserved
10 to 9	R (b00)	R (b00)
8	R/W	R/W
7	Reserved	Reserved
6 to 5	R (b00)	R (b00)
4	R/W	R/W
3	Reserved	Reserved
2 to 1	R (b00)	R (b00)
0	R/W	R/W

**Table 108. COMSTA1 Register**

Name	Address	Default Value	Access
COMSTA1	0xFFFF0718	0x00	R

COMSTA1 is a modem status register.

**Table 109. COMSTA1 MMR Bit Descriptions**

Bit	Name	Description
7	DCD	Data carrier detect.
6	RI	Ring indicator.
5	DSR	Data set ready.
4	CTS	Clear to send.
3	DDCD	Delta DCD. Set automatically if DCD changed state since last COMSTA1 read. Cleared automatically by reading COMSTA1.
2	TERI	Trailing edge RI. Set if RI changed from 0 to 1 since COMSTA1 was last read. Cleared automatically by reading COMSTA1.
1	DDSR	Delta DSR. Set automatically if DSR changed state since COMSTA1 was last read. Cleared automatically by reading COMSTA1.
0	DCTS	Delta CTS. Set automatically if CTS changed state since COMSTA1 was last read. Cleared automatically by reading COMSTA1.

**Table 110. COMSCR Register**

Name	Address	Default Value	Access
COMSCR	0xFFFF071C	0x00	R/W

COMSCR is an 8-bit scratch register used for temporary storage. It is also used in network addressable UART mode.

**Table 111. COMDIV2 Register**

Name	Address	Default Value	Access
COMDIV2	0xFFFF072C	0x0000	R/W

COMDIV2 is a 16-bit fractional baud divide register.

**Table 112. COMDIV2 MMR Bit Descriptions**

Bit	Name	Description
15	FBN	Fractional baud rate generator enable bit. Set by user to enable the fractional baud rate generator. Cleared by user to generate baud rate using the standard 450 UART baud rate generator.
14:13		Reserved.
12:11	FBM[1:0]	M if FBM = 0, M = 4 (see the Fractional Divider section).
10:0	FBN[10:0]	N (see the Fractional Divider section).

### Network Addressable UART Mode

This mode connects the MicroConverter to a 256-node serial network, either as a hardware single master or via software in a multimaster network. Bit 7 (ENAM) of the COMIEN1 register must be set to enable UART in network addressable mode (see Table 114). Note that there is no parity check in this mode.

### Network Addressable UART Register Definitions

Four additional registers, COMIEN0, COMIEN1, COMIID1, and COMADR are used in network addressable UART mode only.

In network address mode, the least significant bit of the COMIEN1 register is the transmitted network address control bit. If set to 1, the device is transmitting an address. If cleared to 0, the device is transmitting data. For example, the following master-based code transmits the slave's address followed by the data:

```
COMIEN1 = 0xE7;           //Setting ENAM,
E9BT, E9BR, ETD, NABP
COMTX = 0xA0;             // Slave address is 0xA0
while(!(0x020==(COMSTA0 & 0x020))){} // wait for adr tx to finish.
COMIEN1 = 0xE6;           // Clear NAB bit to indicate Data is coming
COMTX = 0x55;             // Tx data to slave: 0x55
```

**Table 113. COMIEN1 Register**

Name	Address	Default Value	Access
COMIEN1	0xFFFF0720	0x04	R/W

COMIEN1 is an 8-bit network enable register.

**Table 114. COMIEN1 MMR Bit Descriptions**

Bit	Name	Description
7	ENAM	Network address mode enable bit. Set by user to enable network address mode. Cleared by user to disable network address mode.
6	E9BT	9-bit transmit enable bit. Set by user to enable 9-bit transmit. ENAM must be set. Cleared by user to disable 9-bit transmit.
5	E9BR	9-bit receive enable bit. Set by user to enable 9-bit receive. ENAM must be set. Cleared by user to disable 9-bit receive.
4	ENI	Network interrupt enable bit.
3	E9BD	Word length. Set for 9-bit data. E9BT has to be cleared. Cleared for 8-bit data.
2	ETD	Transmitter pin driver enable bit. Set by user to enable SOUT pin as an output in slave mode or multimaster mode. Cleared by user; SOUT is three-state.
1	NABP	Network address bit. Interrupt polarity bit.
0	NAB	Network address bit (if NABP = 1). Set by user to transmit the slave address. Cleared by user to transmit data.

**Table 115. COMIID1 Register**

Name	Address	Default Value	Access
COMIID1	0xFFFF0724	0x01	R

COMIID1 is an 8-bit network interrupt register. Bit 7 to Bit 4 are reserved (see Table 116).

**Table 140. I2CxDIV Registers**

<b>Name</b>	<b>Address</b>	<b>Default Value</b>	<b>Access</b>
I2C0DIV	0xFFFF0830	0x1F1F	R/W
I2C1DIV	0xFFFF0930	0x1F1F	R/W

I2CxDIV are the clock divider registers.

**Table 141. I2CxIDx Registers**

<b>Name</b>	<b>Address</b>	<b>Default Value</b>	<b>Access</b>
I2C0ID0	0xFFFF0838	0x00	R/W
I2C0ID1	0xFFFF083C	0x00	R/W
I2C0ID2	0xFFFF0840	0x00	R/W
I2C0ID3	0xFFFF0844	0x00	R/W
I2C1ID0	0xFFFF0938	0x00	R/W
I2C1ID1	0xFFFF093C	0x00	R/W
I2C1ID2	0xFFFF0940	0x00	R/W
I2C1ID3	0xFFFF0944	0x00	R/W

I2CxID0, I2CxID1, I2CxID2, and I2CxID3 are slave address device ID registers of I2Cx.

**Table 142. I2CxCCNT Registers**

<b>Name</b>	<b>Address</b>	<b>Default Value</b>	<b>Access</b>
I2C0CCNT	0xFFFF0848	0x01	R/W
I2C1CCNT	0xFFFF0948	0x01	R/W

I2CxCCNT are 8-bit start/stop generation counters. They hold off SDA low for start and stop conditions.

**Table 143. I2CxFSTA Registers**

<b>Name</b>	<b>Address</b>	<b>Default Value</b>	<b>Access</b>
I2C0FSTA	0xFFFF084C	0x0000	R/W
I2C1FSTA	0xFFFF094C	0x0000	R/W

I2CxFSTA are FIFO status registers.

**Table 144. I2C0FSTA MMR Bit Descriptions**

<b>Bit</b>	<b>Access Type</b>	<b>Value</b>	<b>Description</b>
15:10			Reserved.
9	R/W		Master transmit FIFO flush. Set by the user to flush the master Tx FIFO. Cleared automatically when the master Tx FIFO is flushed. This bit also flushes the slave receive FIFO.
8	R/W		Slave transmit FIFO flush. Set by the user to flush the slave Tx FIFO. Cleared automatically after the slave Tx FIFO is flushed.
7:6	R	00 01 10 11	Master Rx FIFO status bits. FIFO empty. Byte written to FIFO. One byte in FIFO. FIFO full.
5:4	R	00 01 10 11	Master Tx FIFO status bits. FIFO empty. Byte written to FIFO. One byte in FIFO. FIFO full.
3:2	R	00 01 10 11	Slave Rx FIFO status bits. FIFO empty. Byte written to FIFO. One byte in FIFO. FIFO full.
1:0	R	00 01 10 11	Slave Tx FIFO status bits. FIFO empty. Byte written to FIFO. One byte in FIFO. FIFO full.

## PROGRAMMABLE LOGIC ARRAY (PLA)

Every ADuC7019/20/21/22/24/25/26/27/28/29 integrates a fully programmable logic array (PLA) that consists of two independent but interconnected PLA blocks. Each block consists of eight PLA elements, giving each part a total of 16 PLA elements.

Each PLA element contains a two-input lookup table that can be configured to generate any logic output function based on two inputs and a flip-flop. This is represented in Figure 76.

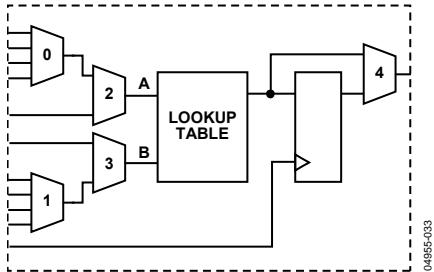


Figure 76. PLA Element

In total, 30 GPIO pins are available on each ADuC7019/20/21/22/24/25/26/27/28/29 for the PLA. These include 16 input pins and 14 output pins, which must be configured in the GPxCON register as PLA pins before using the PLA. Note that the comparator output is also included as one of the 16 input pins.

The PLA is configured via a set of user MMRs. The output(s) of the PLA can be routed to the internal interrupt system, to the CONV<sub>START</sub> signal of the ADC, to an MMR, or to any of the 16 PLA output pins.

The two blocks can be interconnected as follows:

- Output of Element 15 (Block 1) can be fed back to Input 0 of Mux 0 of Element 0 (Block 0).
- Output of Element 7 (Block 0) can be fed back to the Input 0 of Mux 0 of Element 8 (Block 1).

Table 145. Element Input/Output

PLA Block 0			PLA Block 1		
Element	Input	Output	Element	Input	Output
0	P1.0	P1.7	8	P3.0	P4.0
1	P1.1	P0.4	9	P3.1	P4.1
2	P1.2	P0.5	10	P3.2	P4.2
3	P1.3	P0.6	11	P3.3	P4.3
4	P1.4	P0.7	12	P3.4	P4.4
5	P1.5	P2.0	13	P3.5	P4.5
6	P1.6	P2.1	14	P3.6	P4.6
7	P0.0	P2.2	15	P3.7	P4.7

### PLA MMRs Interface

The PLA peripheral interface consists of the 22 MMRs described in this section.

Table 146. PLAELMx Registers

Name	Address	Default Value	Access
PLAELM0	0xFFFFF0B00	0x0000	R/W
PLAELM1	0xFFFFF0B04	0x0000	R/W
PLAELM2	0xFFFFF0B08	0x0000	R/W
PLAELM3	0xFFFFF0B0C	0x0000	R/W
PLAELM4	0xFFFFF0B10	0x0000	R/W
PLAELM5	0xFFFFF0B14	0x0000	R/W
PLAELM6	0xFFFFF0B18	0x0000	R/W
PLAELM7	0xFFFFF0B1C	0x0000	R/W
PLAELM8	0xFFFFF0B20	0x0000	R/W
PLAELM9	0xFFFFF0B24	0x0000	R/W
PLAELM10	0xFFFFF0B28	0x0000	R/W
PLAELM11	0xFFFFF0B2C	0x0000	R/W
PLAELM12	0xFFFFF0B30	0x0000	R/W
PLAELM13	0xFFFFF0B34	0x0000	R/W
PLAELM14	0xFFFFF0B38	0x0000	R/W
PLAELM15	0xFFFFF0B3C	0x0000	R/W

PLAELMx are Element 0 to Element 15 control registers. They configure the input and output mux of each element, select the function in the lookup table, and bypass/use the flip-flop. See Table 147 and Table 152.

Table 147. PLAELMx MMR Bit Descriptions

Bit	Value	Description
31:11		Reserved.
10:9		Mux 0 control (see Table 152).
8:7		Mux 1 control (see Table 152).
6		Mux 2 control. Set by user to select the output of Mux 0. Cleared by user to select the bit value from PLADIN.
5		Mux 3 control. Set by user to select the input pin of the particular element. Cleared by user to select the output of Mux 1.
4:1		Lookup table control.
	0000	0.
	0001	NOR.
	0010	B AND NOT A.
	0011	NOT A.
	0100	A AND NOT B.
	0101	NOT B.
	0110	EXOR.
	0111	NAND.
	1000	AND.
	1001	EXNOR.
	1010	B.
	1011	NOT A OR B.
	1100	A.
	1101	A OR NOT B.
	1110	OR.
	1111	1.
0		Mux 4 control. Set by user to bypass the flip-flop. Cleared by user to select the flip-flop (cleared by default).

## PROCESSOR REFERENCE PERIPHERALS

### INTERRUPT SYSTEM

There are 23 interrupt sources on the ADuC7019/20/21/22/24/25/26/27/28/29 that are controlled by the interrupt controller. Most interrupts are generated from the on-chip peripherals, such as ADC and UART. Four additional interrupt sources are generated from external interrupt request pins, IRQ0, IRQ1, IRQ2, and IRQ3. The ARM7TDMI CPU core only recognizes interrupts as one of two types: a normal interrupt request IRQ or a fast interrupt request FIQ. All the interrupts can be masked separately.

The control and configuration of the interrupt system are managed through nine interrupt-related registers, four dedicated to IRQ, and four dedicated to FIQ. An additional MMR is used to select the programmed interrupt source. The bits in each IRQ and FIQ register (except for Bit 23) represent the same interrupt source as described in Table 160.

**Table 160. IRQ/FIQ MMRs Bit Description**

Bit	Description
0	All interrupts OR'ed (FIQ only)
1	SWI
2	Timer0
3	Timer1
4	Wake-up timer (Timer2)
5	Watchdog timer (Timer3)
6	Flash control
7	ADC channel
8	PLL lock
9	I2C0 slave
10	I2C0 master
11	I2C1 master
12	SPI slave
13	SPI master
14	UART
15	External IRQ0
16	Comparator
17	PSM
18	External IRQ1
19	PLA IRQ0
20	PLA IRQ1
21	External IRQ2
22	External IRQ3
23	PWM trip (IRQ only)/PWM sync (FIQ only)

### IRQ

The interrupt request (IRQ) is the exception signal to enter the IRQ mode of the processor. It is used to service general-purpose interrupt handling of internal and external events.

The four 32-bit registers dedicated to IRQ are IRQSTA, IRQSIG, IRQEN, and IRQCLR.

**Table 161. IRQSTA Register**

Name	Address	Default Value	Access
IRQSTA	0xFFFF0000	0x00000000	R

IRQSTA (read-only register) provides the current-enabled IRQ source status. When set to 1, that source should generate an active IRQ request to the ARM7TDMI core. There is no priority encoder or interrupt vector generation. This function is implemented in software in a common interrupt handler routine. All 32 bits are logically OR'd to create the IRQ signal to the ARM7TDMI core.

**Table 162. IRQSIG Register**

Name	Address	Default Value	Access
IRQSIG	0xFFFF0004	0x00XXX000 <sup>1</sup>	R

<sup>1</sup>X indicates an undefined value.

IRQSIG reflects the status of the different IRQ sources. If a peripheral generates an IRQ signal, the corresponding bit in the IRQSIG is set; otherwise, it is cleared. The IRQSIG bits are cleared when the interrupt in the particular peripheral is cleared. All IRQ sources can be masked in the IRQEN MMR. IRQSIG is read only.

**Table 163. IRQEN Register**

Name	Address	Default Value	Access
IRQEN	0xFFFF0008	0x00000000	R/W

IRQEN provides the value of the current enable mask. When each bit is set to 1, the source request is enabled to create an IRQ exception. When each bit is set to 0, the source request is disabled or masked, which does not create an IRQ exception.

Note that to clear an already enabled interrupt source, the user must set the appropriate bit in the IRQCLR register. Clearing an interrupt's IRQEN bit does not disable the interrupt.

**Table 164. IRQCLR Register**

Name	Address	Default Value	Access
IRQCLR	0xFFFF000C	0x00000000	W

IRQCLR (write-only register) clears the IRQEN register in order to mask an interrupt source. Each bit set to 1 clears the corresponding bit in the IRQEN register without affecting the remaining bits. The pair of registers, IRQEN and IRQCLR, independently manipulates the enable mask without requiring an atomic read-modify-write.

Table 186. T2CON MMR Bit Descriptions

Bit	Value	Description
31:11		Reserved.
10:9	00	Clock source. External crystal.
	01	External crystal.
	10	Internal oscillator.
	11	Core clock (41 MHz/2 <sup>CD</sup> ).
8		Count up. Set by user for Timer2 to count up. Cleared by user for Timer2 to count down by default.
7		Timer2 enable bit. Set by user to enable Timer2. Cleared by user to disable Timer2 by default.
6		Timer2 mode. Set by user to operate in periodic mode. Cleared by user to operate in free-running mode. Default mode.
5:4	00	Format. Binary.
	01	Reserved.
	10	Hr: min: sec: Hundredths (23 hours to 0 hour).
	11	Hr: min: sec: Hundredths (255 hours to 0 hour).
3:0	0000	Prescale. Source Clock/1 by default.
	0100	Source Clock/16.
	1000	Source Clock/256 expected for Format 2 and Format 3.
	1111	Source Clock/32,768.

Table 187. T2CLRI Register

Name	Address	Default Value	Access
T2CLRI	0xFFFF034C	0xFF	W

T2CLRI is an 8-bit register. Writing any value to this register clears the Timer2 interrupt.

### Timer3 (Watchdog Timer)

Timer3 has two modes of operation: normal mode and watchdog mode. The watchdog timer is used to recover from an illegal software state. Once enabled, it requires periodic servicing to prevent it from forcing a processor reset.

#### Normal Mode

Timer3 in normal mode is identical to Timer0, except for the clock source and the count-up functionality. The clock source is 32 kHz from the PLL and can be scaled by a factor of 1, 16, or 256 (see Figure 80).

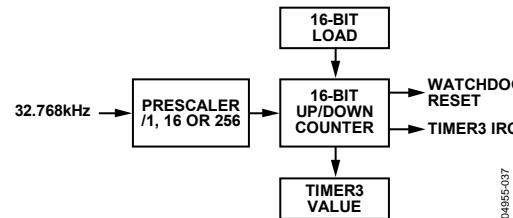


Figure 80. Timer3 Block Diagram

#### Watchdog Mode

Watchdog mode is entered by setting Bit 5 in the T3CON MMR. Timer3 decreases from the value present in the T3LD register to 0. T3LD is used as the timeout. The maximum timeout can be 512 sec, using the prescaler/256, and full scale in T3LD. Timer3 is clocked by the internal 32 kHz crystal when operating in watchdog mode. Note that to enter watchdog mode successfully, Bit 5 in the T3CON MMR must be set after writing to the T3LD MMR.

If the timer reaches 0, a reset or an interrupt occurs, depending on Bit 1 in the T3CON register. To avoid reset or interrupt, any value must be written to T3CLRI before the expiration period. This reloads the counter with T3LD and begins a new timeout period.

When watchdog mode is entered, T3LD and T3CON are write-protected. These two registers cannot be modified until a reset clears the watchdog enable bit, which causes Timer3 to exit watchdog mode.

The Timer3 interface consists of four MMRs: T3LD, T3VAL, T3CON, and T3CLRI.

Table 188. T3LD Register

Name	Address	Default Value	Access
T3LD	0xFFFF0360	0x0000	R/W

T3LD is a 16-bit register load register.

Table 189. T3VAL Register

Name	Address	Default Value	Access
T3VAL	0xFFFF0364	0xFFFF	R

T3VAL is a 16-bit read-only register that represents the current state of the counter.

Table 190. T3CON Register

Name	Address	Default Value	Access
T3CON	0xFFFF0368	0x0000	R/W

T3CON is the configuration MMR described in Table 191.

## GROUNDING AND BOARD LAYOUT RECOMMENDATIONS

As with all high resolution data converters, special attention must be paid to grounding and PC board layout of the ADuC7019/20/21/22/24/25/26/27/28/29-based designs to achieve optimum performance from the ADCs and DAC.

Although the parts have separate pins for analog and digital ground (AGND and IOGND), the user must not tie these to two separate ground planes unless the two ground planes are connected very close to the part. This is illustrated in the simplified example shown in Figure 91a. In systems where digital and analog ground planes are connected together somewhere else (at the system power supply, for example), the planes cannot be reconnected near the part because a ground loop results. In these cases, tie all the ADuC7019/20/21/22/24/25/26/27/28/29 AGND and IOGND pins to the analog ground plane, as illustrated in Figure 91b. In systems with only one ground plane, ensure that the digital and analog components are physically separated onto separate halves of the board so that digital return currents do not flow near analog circuitry (and vice versa).

The ADuC7019/20/21/22/24/25/26/27/28/29 can then be placed between the digital and analog sections, as illustrated in Figure 91c.

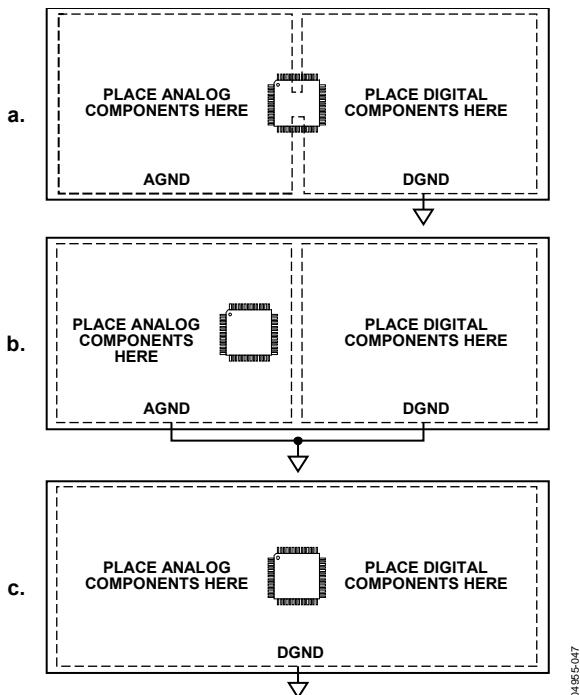


Figure 91. System Grounding Schemes

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In all of these scenarios, and in more complicated real-life applications, the user should pay particular attention to the flow of current from the supplies and back to ground. Make sure the return paths for all currents are as close as possible to the paths the currents took to reach their destinations.

For example, do not power components on the analog side (as seen in Figure 91b) with IOV<sub>DD</sub> because that forces return currents from IOV<sub>DD</sub> to flow through AGND. Avoid digital currents flowing under analog circuitry, which can occur if a noisy digital chip is placed on the left half of the board (shown in Figure 91c). If possible, avoid large discontinuities in the ground plane(s) such as those formed by a long trace on the same layer because they force return signals to travel a longer path. In addition, make all connections to the ground plane directly, with little or no trace separating the pin from its via to ground.

When connecting fast logic signals (rise/fall time < 5 ns) to any of the ADuC7019/20/21/22/24/25/26/27/28/29 digital inputs, add a series resistor to each relevant line to keep rise and fall times longer than 5 ns at the part's input pins. A value of 100 Ω or 200 Ω is usually sufficient to prevent high speed signals from coupling capacitively into the part and affecting the accuracy of ADC conversions.

## CLOCK OSCILLATOR

The clock source for the ADuC7019/20/21/22/24/25/26/27/28/29 can be generated by the internal PLL or by an external clock input. To use the internal PLL, connect a 32.768 kHz parallel resonant crystal between XCLKI and XCLKO, and connect a capacitor from each pin to ground as shown in Figure 92. The crystal allows the PLL to lock correctly to give a frequency of 41.78 MHz. If no external crystal is present, the internal oscillator is used to give a typical frequency of 41.78 MHz ± 3%.

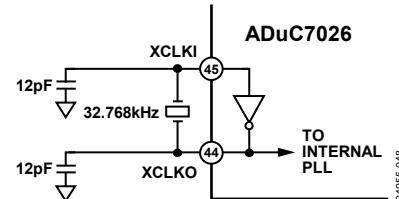


Figure 92. External Parallel Resonant Crystal Connections

To use an external source clock input instead of the PLL (see Figure 93), Bit 1 and Bit 0 of PLLCON must be modified. The external clock uses P0.7 and XCLK.

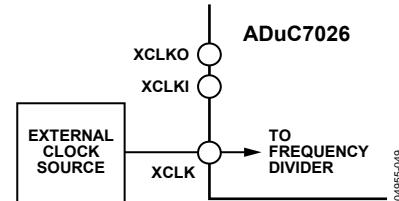


Figure 93. Connecting an External Clock Source

Using an external clock source, the ADuC7019/20/21/22/24/25/26/27/28/29-specified operational clock speed range is 50 kHz to 44 MHz ± 1%, which ensures correct operation of the analog peripherals and Flash/EE.

## POWER-ON RESET OPERATION

An internal power-on reset (POR) is implemented on the ADuC7019/20/21/22/24/25/26/27/28/29. For  $LV_{DD}$  below 2.35 V typical, the internal POR holds the part in reset. As  $LV_{DD}$  rises above 2.35 V, an internal timer times out for, typically, 128 ms before the part is released from reset. The user must ensure that the power supply  $IOV_{DD}$  reaches a stable 2.7 V minimum level by this time. Likewise, on power-down, the internal POR holds the part in reset until  $LV_{DD}$  drops below 2.35 V.

Figure 94 illustrates the operation of the internal POR in detail.

## TYPICAL SYSTEM CONFIGURATION

A typical ADuC7020 configuration is shown in Figure 95. It summarizes some of the hardware considerations discussed in the previous sections. The bottom of the CSP package has an exposed pad that must be soldered to a metal plate on the board for mechanical reasons. The metal plate of the board can be connected to ground.

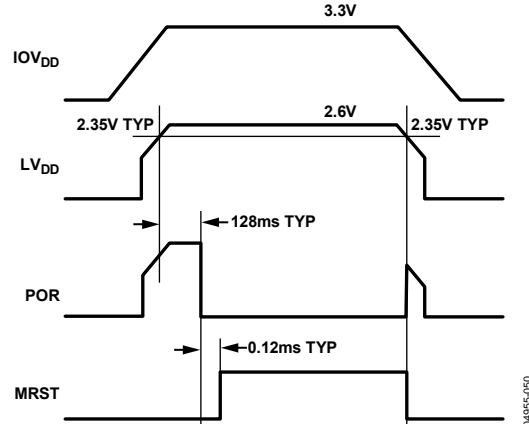


Figure 94. Internal Power-On Reset Operation

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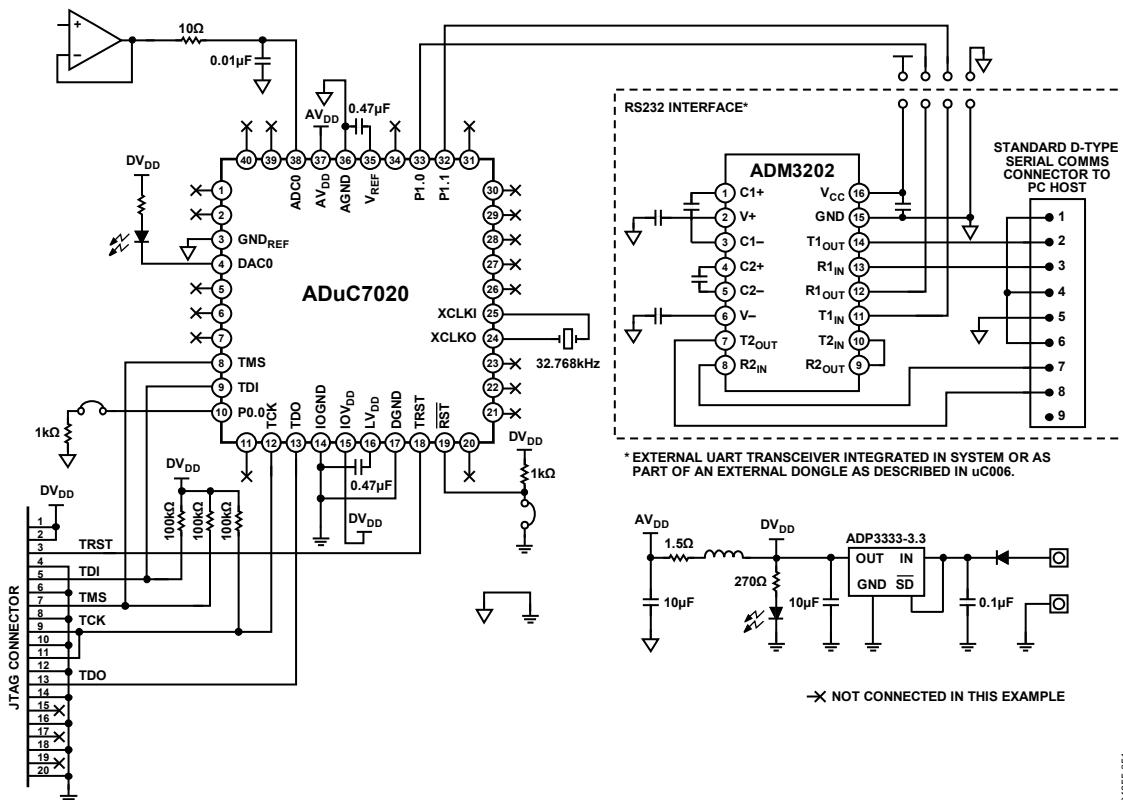


Figure 95. Typical System Configuration

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